

ISO/TR 5602:2021-11 (E)

Sources of error in the use of electrochemical impedance spectroscopy for the investigation of coatings and other materials

Contents		Page
Foreword		v
Introduction		vi
1	Scope	1
2	Normative references	1
3	Terms and definitions	1
4	Error in the make-up of the measuring cell	1
4.1	Roughness of the surface	1
4.2	O-ring -- Considerations about the precise determination of the exposed area	3
4.3	Faulty cell make-up	7
4.3.1	Optically detectable leaks	7
4.3.2	Optically non-detectable causes	7
4.4	Reference electrodes	9
4.4.1	General information on the distance between the reference and working electrodes	9
4.4.2	Shielding	11
4.4.3	Air bubble in the reference electrode	11
4.4.4	Poisoning of the reference electrode	11
4.4.5	Bleeding of the reference electrode	11
4.5	Counter electrodes	11
4.5.1	Relative sizes	11
4.5.2	Reactive counter electrodes	11
4.6	Gas inclusions in the measuring cell	11
5	Faults caused by electronics incl. shielding	12
5.1	Faraday cage	12
5.2	Extended cable (without active shielding)	15
5.3	Cable breaks	16
5.4	Contact resistances between metallic contacts and the working electrode/counter electrode	17
5.5	Inductivities	18
5.6	Measurement range switching	19
5.7	Scattering signals in power supply	20
5.8	Insufficient signal-to-noise ratio	22
5.9	Influence of peripheral devices	22
6	Parameter selection, measurement range limits	24
6.1	Open-lead test	24
6.2	Note on dummy cells - ISO 16773-3	24
6.3	Unsuitable amplitude	24
6.4	Insufficient frequency range	26
6.5	Repetition rate for subsequent measurements	27
7	Non-stationary measurement conditions	28
7.1	General	28
7.2	Temperature fluctuations	29
7.3	Electrolytic conductivity	31
7.4	Swelling	31

7.5	Drifting OCP	31
7.6	Corroding working electrode	33
7.7	Reactive counter electrodes	33
7.8	Gas formation at the counter electrode	33
8	Design and selection of equivalent circuit diagrams	34
8.1	Constant phase element	34
8.2	Multiple possibilities for the selection of equivalent circuits	35
8.3	Warburg impedance	37
9	Significance of measurement values from equivalent circuits	37
9.1	Measurement uncertainty	37
9.2	Plausibility analysis	38
10	Interpretation of the measurement values of various coating systems	39
10.1	Pre-treatment	39
10.2	Film thickness and measurement surface	40
10.3	Number of layers	41
10.4	Conditioning	45
10.5	Generic type of binder	45
11	Presentation of data	45
Annex A (informative) Calculation of the coating capacitance		48
Annex B (informative) Further information on the influence of the double-layer capacitance		49
Annex C (informative) Estimation of the order of magnitude of an apparent capacitance caused by corrosion		50
Bibliography		52